

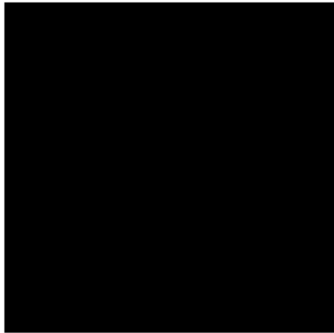
Detector H08-W0276

1 Detector Details and Basic Parameters

Readout: MiniPIX (sn: 105)
Full Name: MiniPIX H08-W0276
Chip: Timepix
Sensor: Si (300 μm)
Temperature: 22.0
Pixet Version: 1.4.10.706
TpxSetup Version: 1.9 (31.7.2018)
Date: 04.10.2018 11:53:06
Responsible: Matous

| Parameter | Value | Reason |
|---------------|-------|----------------------------------|
| Timepix Clock | 10.0 | Noise reduction |
| Ikrom | 1 | Better energy resolution |
| FBK | 157 | Wider energy range in ToT mode |
| THL Coarse | 8 | Wider energy range of threshold |
| Preamp | 225 | Lower power consumption and heat |

2 Digital Test and Bias Test

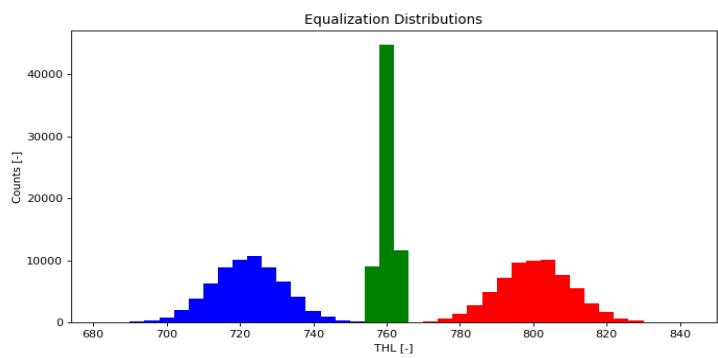


Bad Pixels: 0

3 Bias Leakage Test

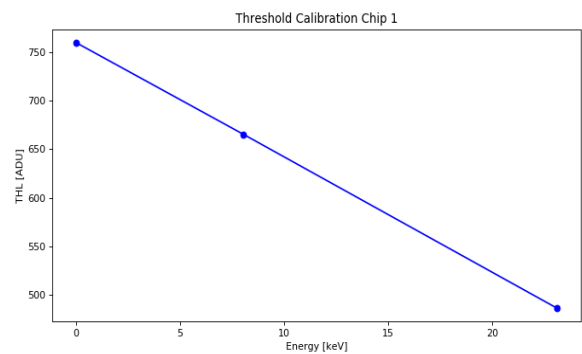
| Bias [V] | Leaking Pixels [cnt] | Leaking Current [μA] | Voltage Sense [V] |
|----------|----------------------|-----------------------------------|-------------------|
| 0 | 0.0000 | 0.0000 | 0.0000 |
| 20 | 0.0000 | 0.0000 | 0.0000 |
| 40 | 0.0000 | 0.0000 | 0.0000 |
| 60 | 0.0000 | 0.0000 | 0.0000 |
| 80 | 0.0000 | 0.0000 | 0.0000 |
| 100 | 0.0000 | 0.0000 | 0.0000 |
| 120 | 0.0000 | 0.0000 | 0.0000 |
| 140 | 0.0000 | 0.0000 | 0.0000 |
| 160 | 0.0000 | 0.0000 | 0.0000 |
| 180 | 0.0000 | 0.0000 | 0.0000 |
| 200 | 0.0000 | 0.0000 | 0.0000 |

4 Threshold Equalization



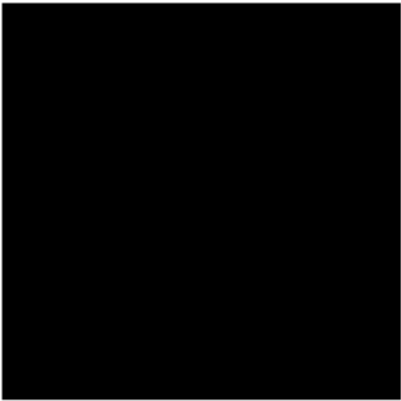
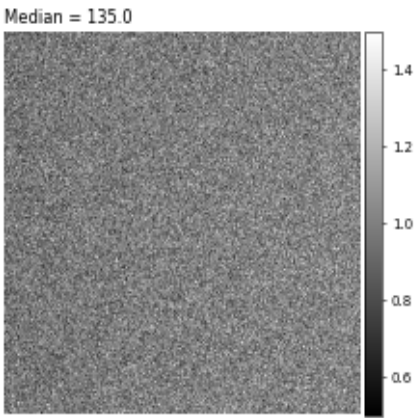
| Parameter | Value |
|---------------|---------|
| Mean THL | 760.162 |
| Std. Dev | 2.247 |
| Masked Pixels | 0 |
| Final THL | 728 |

5 Threshold Energy Calibration



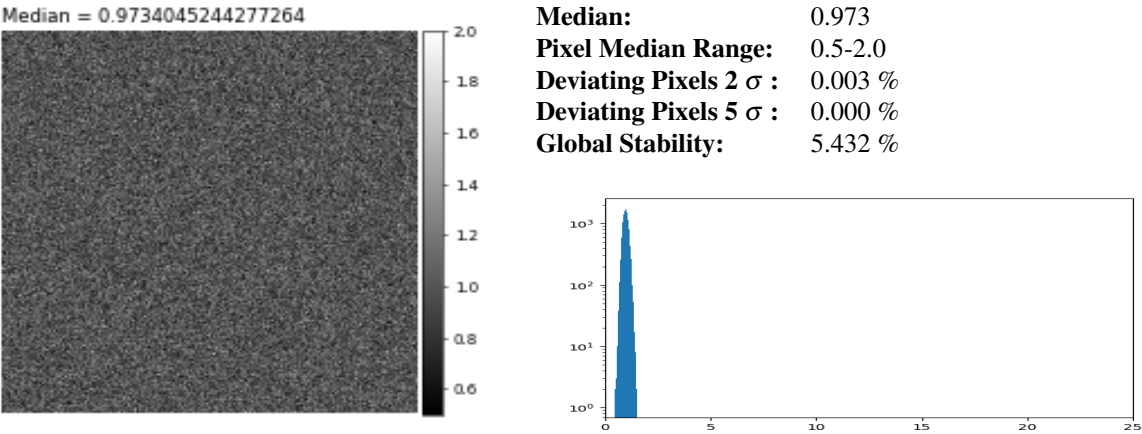
| Parameter | Value |
|----------------|-----------|
| A | 11.919 |
| B | 38.705 |
| W | 0.171 |
| T | 5.317 |
| K | 1.000 |
| Min. Threshold | 2.793 keV |
| THL 5 keV | 701.697 |

6 Bad Pixels Test with X-Ray

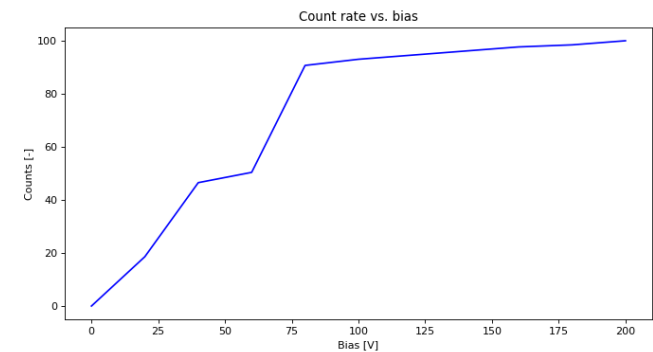


Bad Pixels: 0

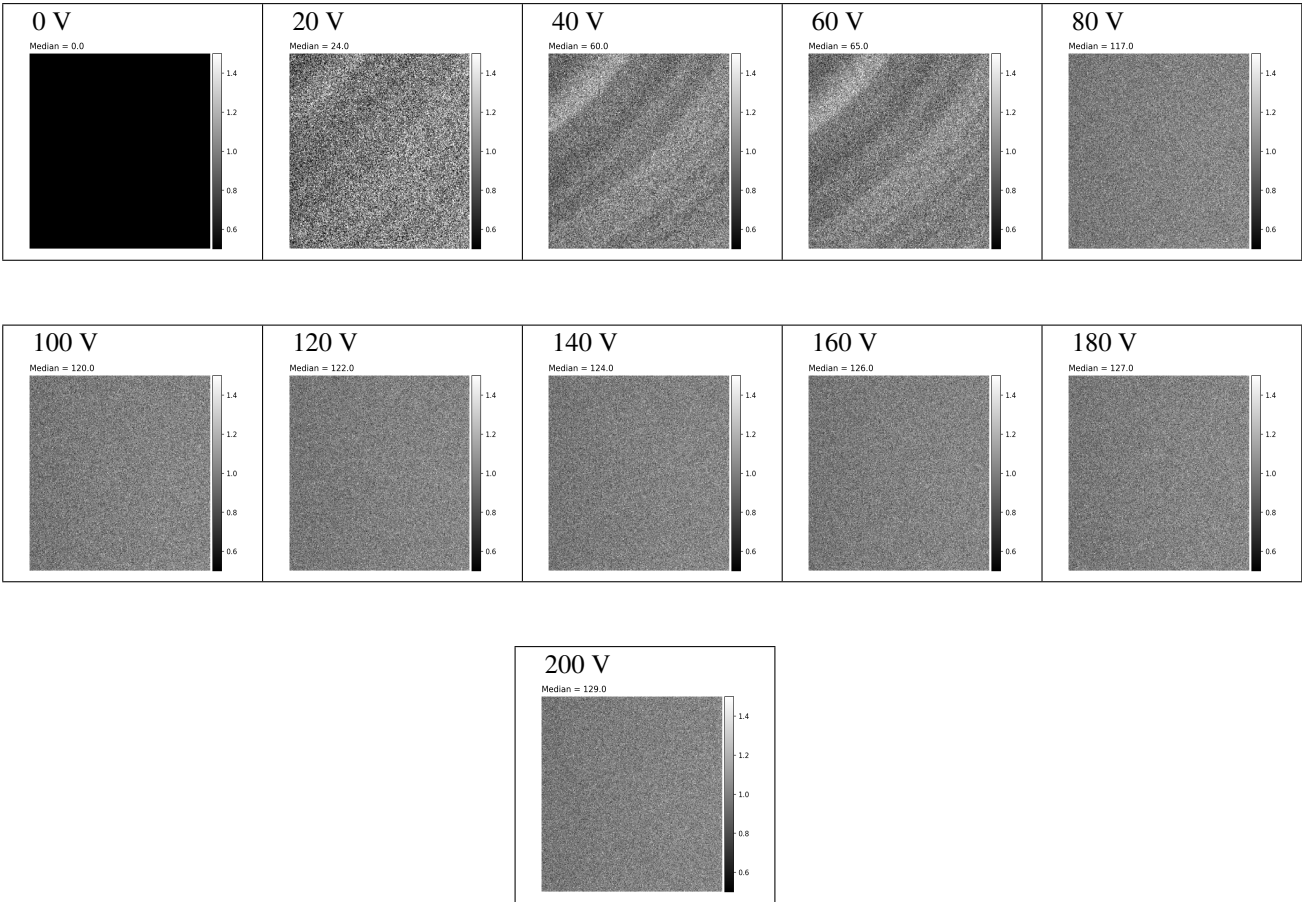
7 Stability Test with Cd XRF 23.106 keV, duration: 10.0 min



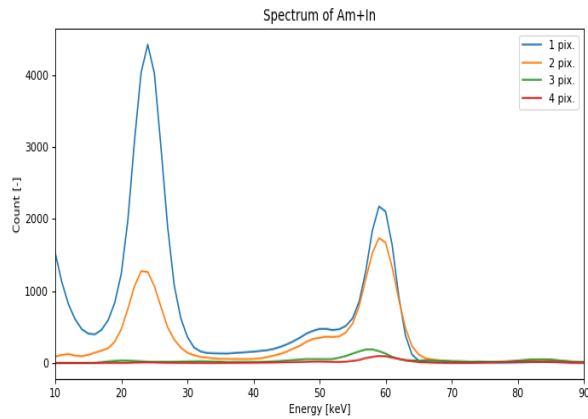
8 Bias Test with Fe XRF (6.4keV)



| Parameter | Value |
|-----------|-------|
| Bias From | 160 |
| Bias To | 200 |
| Bias Step | 20 |



9 Energy Calibration in ToT Mode

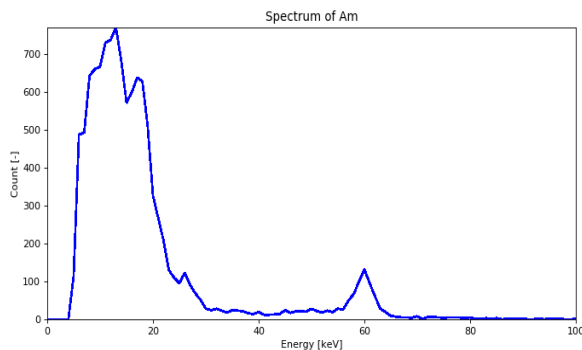


| Source | Energy | 1 | 2 | 3 | 4 |
|--------|--------|--------|--------|--------|--------|
| Fe | 5.905 | 5.489 | 10.636 | 3.000 | 3.000 |
| In | 24.328 | 24.011 | 23.502 | 19.647 | 23.607 |
| Am | 59.598 | 59.487 | 59.411 | 57.674 | 59.453 |

| Coefficient | Mean value |
|-------------|------------|
| A | 1.000 |
| B | 26.000 |
| C | 24.000 |
| T | 4.000 |

10 Calibration Verification

Verification from the front side of the detector



| Source | Energy | Sigma |
|--------|--------|-------|
| Am | 59.527 | 2.654 |

11 Summary and Classification

Calibrated for threshold of 5 keV (THL=701)

| Criterion | Value | Unit | Class |
|------------------------------------|-------|------|-------|
| ROC (Wafer probing result) | - | - | A |
| Masked pixels | 0 | cnt | AA |
| Bad pixels after test with sources | 0 | cnt | AA |
| Largest bad cluster pixel count | 0 | cnt | AA |
| Min. threshold Medipix mode | 2.793 | keV | AA |
| Energy resolution ToT at 60 keV | 1.985 | keV | AA |

| Final Statement | Class | Verbal |
|--------------------------------------|-------|-----------|
| Imaging applications (Counting mode) | AA | Excellent |
| Tracking applications (Energy mode) | AA | Excellent |